

**Features**

- 600V, 4A
- $R_{DS(ON)} = 2.0 \Omega$  (Typ.) @  $V_{GS} = 10V$
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS Compliant

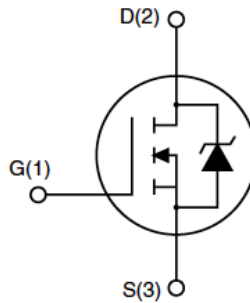
**Application**

- High frequency switching mode power supply
- Uninterruptible Power Supply (UPS)
- Electronic ballast

**Package**



TO-252



**Ordering Information**

Part Number	Marking	Case	Packaging
G4N60K	4N60A	TO-252	2500pcs/Reel

**Absolute Maximum Ratings**  $T_C=25^\circ C$  unless otherwise specified

Symbol	Parameter		Max.	Units
			TO-252	
$V_{DSS}$	Drain-Source Voltage		600	V
$V_{GSS}$	Gate-Source Voltage		$\pm 30$	V
$I_D$	Continuous Drain Current	$T_C = 25^\circ C$	4*	A
		$T_C = 100^\circ C$	2.78*	A
$I_{DM}$	Pulsed Drain Current <sup>note1</sup>		16*	A
$E_{AS}$	Single Pulsed Avalanche Energy <sup>note2</sup>		180	mJ
dv/dt	Peak Diode Recovery Energy <sup>note3</sup>		4.8	V/ns
$P_D$	Power Dissipation	$T_C = 25^\circ C$	44.6	W
	Linear Derating Factor	$T_C > 25^\circ C$	0.357	W/ $^\circ C$
$R_{\theta JC}$	Thermal Resistance, Junction to Case		2.8	$^\circ C/W$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

\*Drain current limited by maximum junction temperature

## Electrical Characteristics $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
<b>Off Characteristic</b>						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	600	-	-	V
$\frac{\Delta V_{(BR)DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D = 250\mu A$	-	0.65	-	$V/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	-	-	1	$\mu A$
		$V_{DS} = 480V, T_C = 125^\circ\text{C}$	-	-	10	$\mu A$
$I_{GSS}$	Gate to Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 30V$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage <sup>note4</sup>	$V_{DS} = V_{GS}, I_D = 250\mu A$	2	3	4	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 2A$	-	2.0	2.3	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 30V, I_D = 2A$	-	5.5	-	S
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	-	511	-	pF
$C_{oss}$	Output Capacitance		-	56.6	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	5.55	-	pF
$Q_g$	Total Gate Charge	$V_{DD} = 480V, I_D = 4A,$ $V_{GS} = 10V$	-	15.3	-	nC
$Q_{gs}$	Gate-Source Charge		-	2.45	-	nC
$Q_{gd}$	Gate-Drain("Miller") Charge		-	6.56	-	nC
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 300V, I_D = 4A,$ $R_G = 10\Omega, V_{GS} = 10V$	-	11.3	-	ns
$t_r$	Turn-On Rise Time		-	14.7	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	37.6	-	ns
$t_f$	Turn-Off Fall Time		-	10.4	-	ns
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current		-	-	4	A
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current		-	-	16	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_S = 2A$	-	-	1.5	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0V, I_F = 4A,$ $di/dt = 100A/\mu s$	-	315	-	ns
$Q_{rr}$	Reverse Recovery Charge		-	1.83	-	$\mu C$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 10\text{mH}, I_{AS} = 6A, V_{DD} = 50V, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 4A, di/dt \leq 200A/\mu s, V_{DD} \leq B_{VDSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

Typical Performance Characteristics

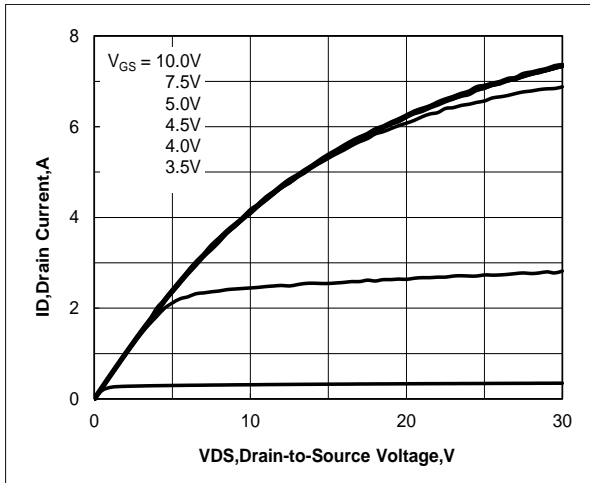


Figure 1. Output Characteristics

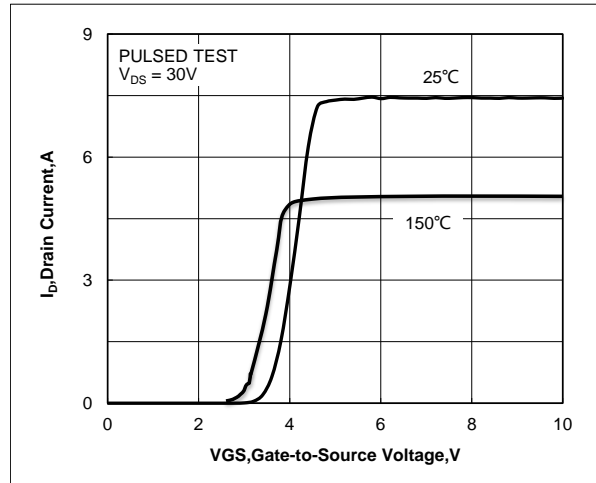


Figure 2. Transfer Characteristics

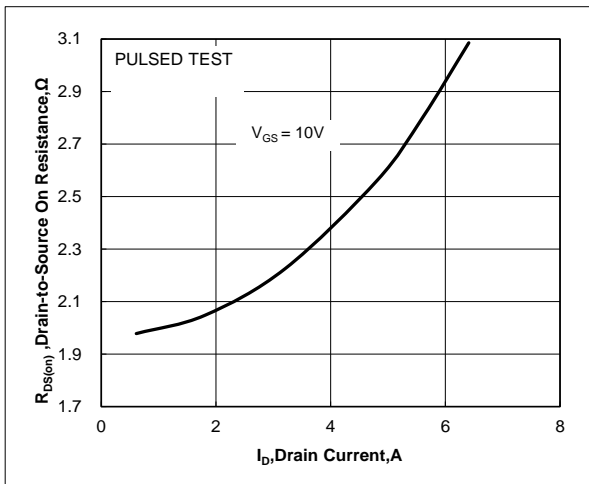


Figure 3. Drain-to-Source On Resistance vs. Drain Current and Gate Voltage

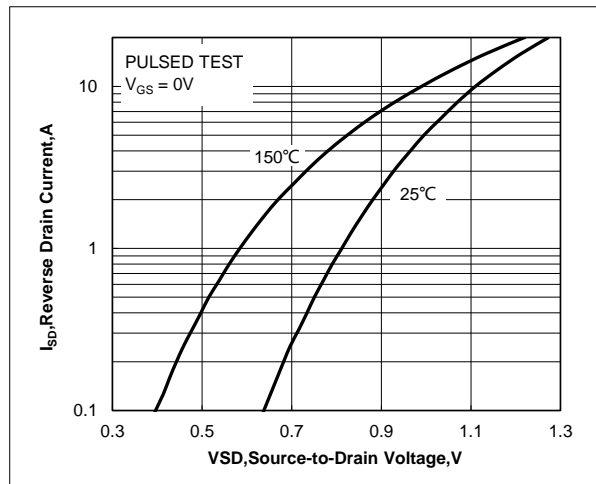


Figure 4. Body Diode Forward Voltage vs. Source Current and Temperature

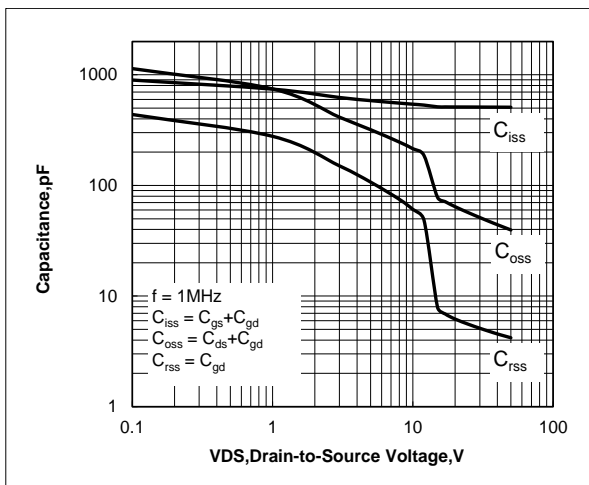


Figure 5. Capacitance Characteristics

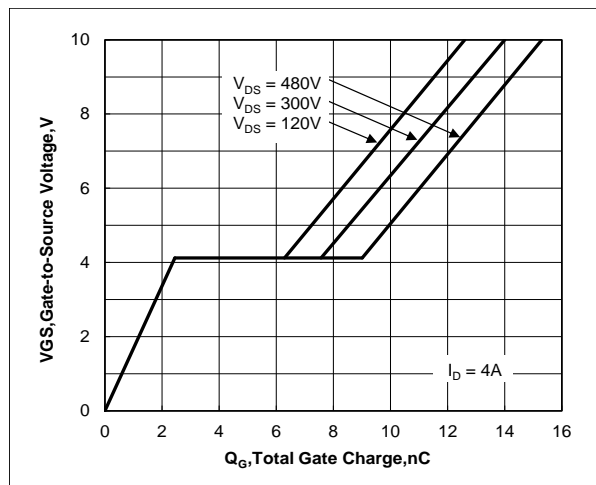


Figure 6. Gate Charge Characteristics

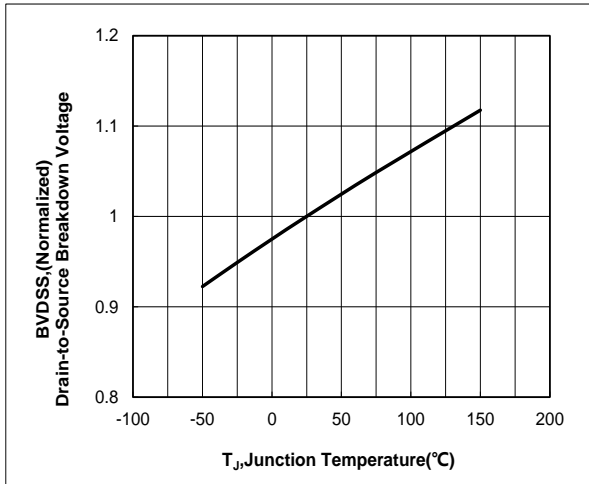


Figure 7. Normalized Breakdown Voltage vs. Junction Temperature

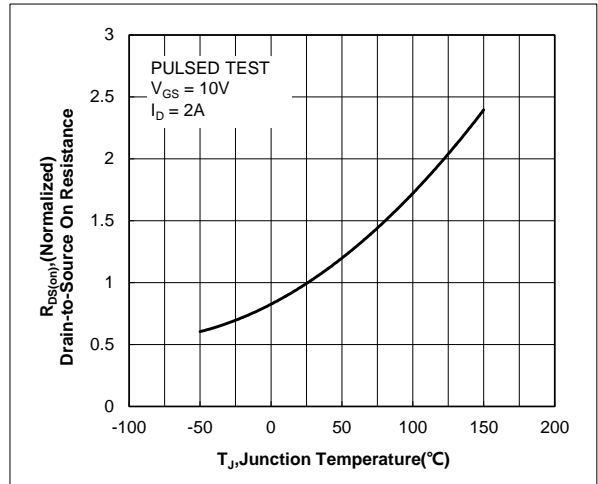


Figure 8. Normalized On Resistance vs. Junction Temperature

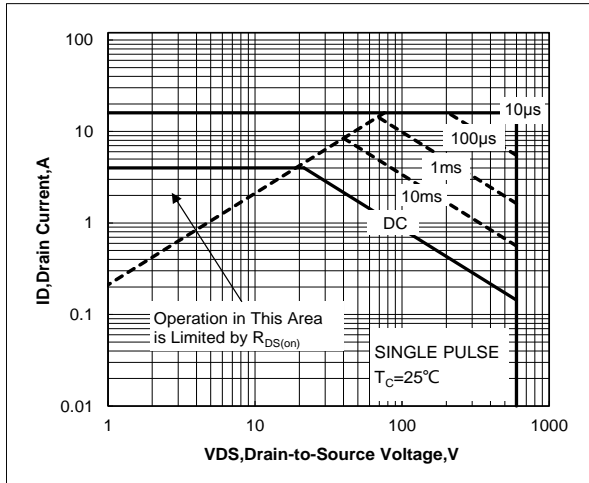


Figure 9. Maximum Safe Operating Area

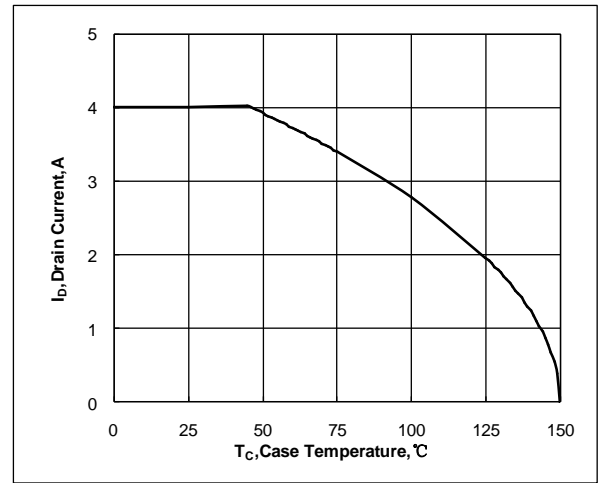


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

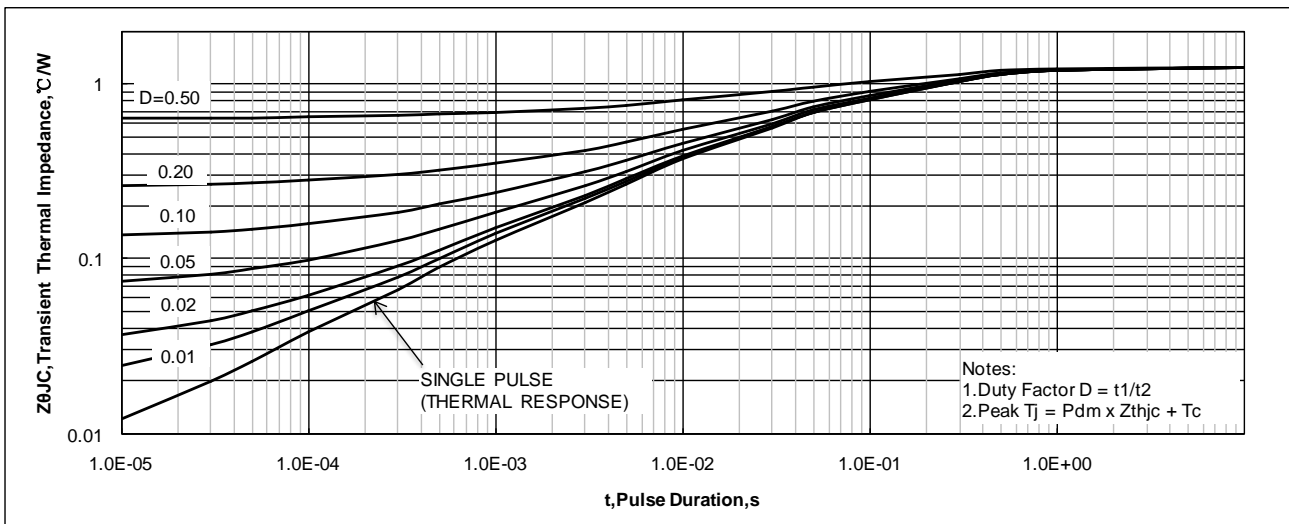


Figure 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

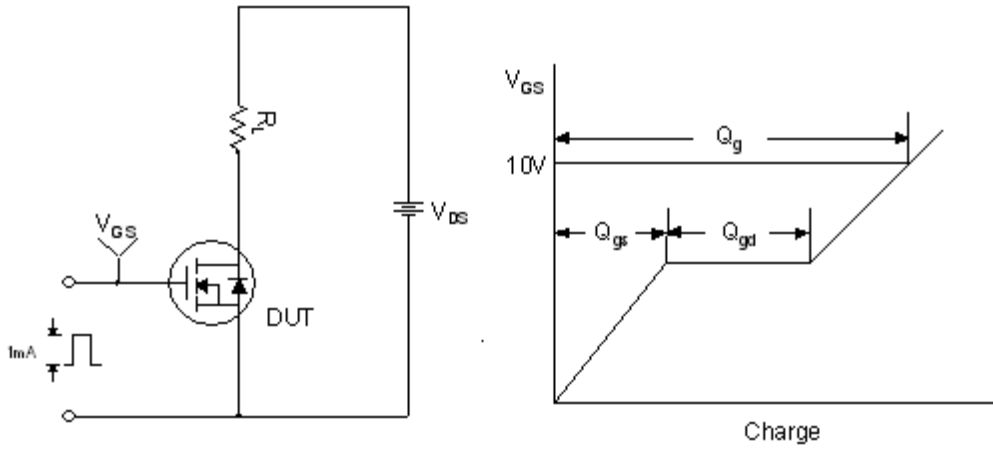


Figure 12. Gate Charge Test Circuit & Waveform

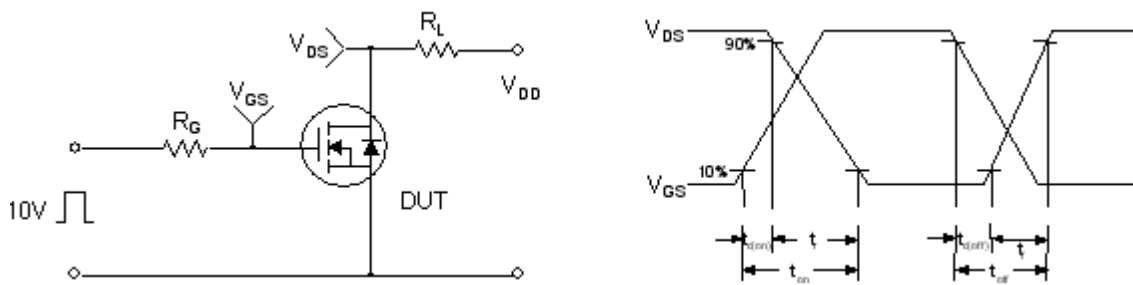


Figure 13. Resistive Switching Test Circuit & Waveforms

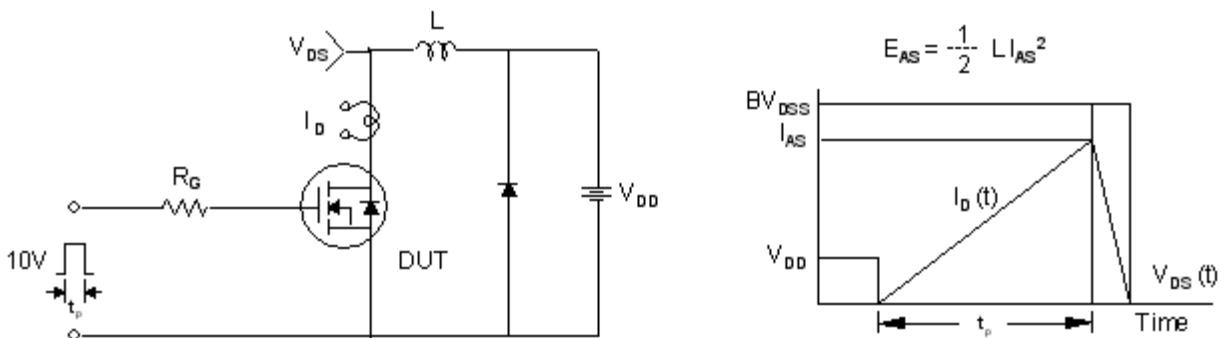


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

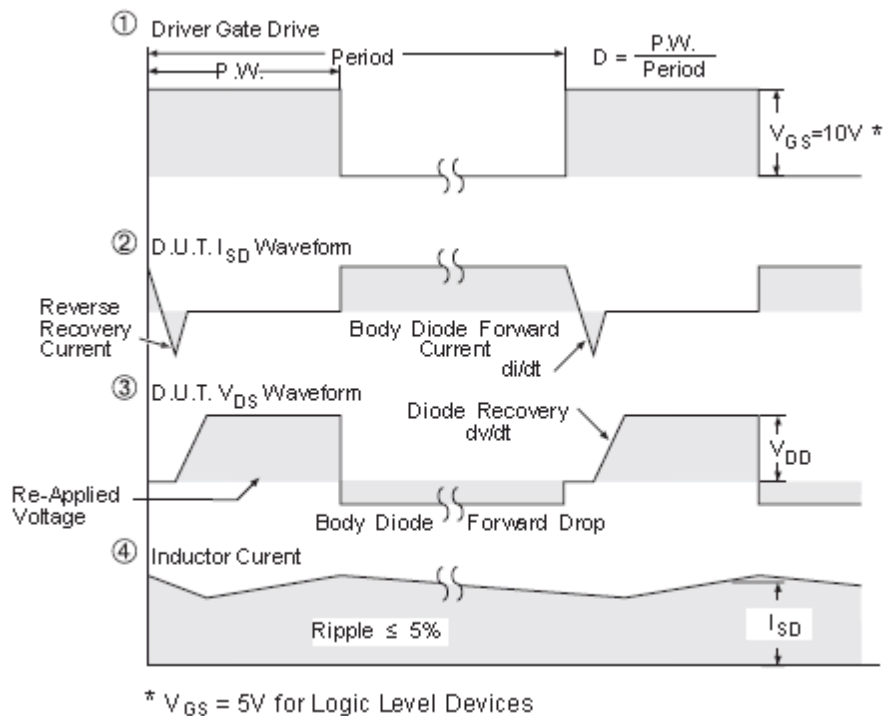
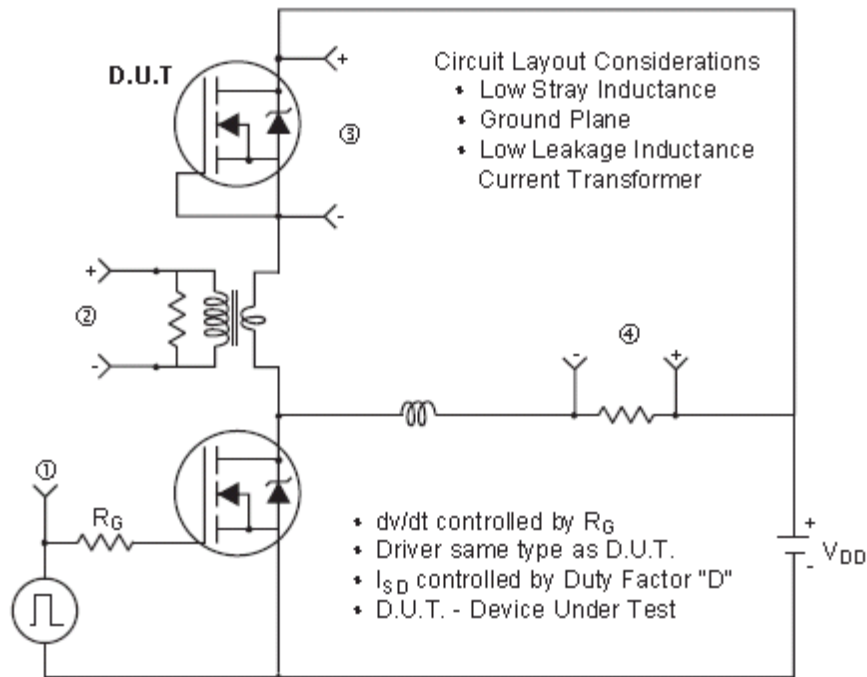
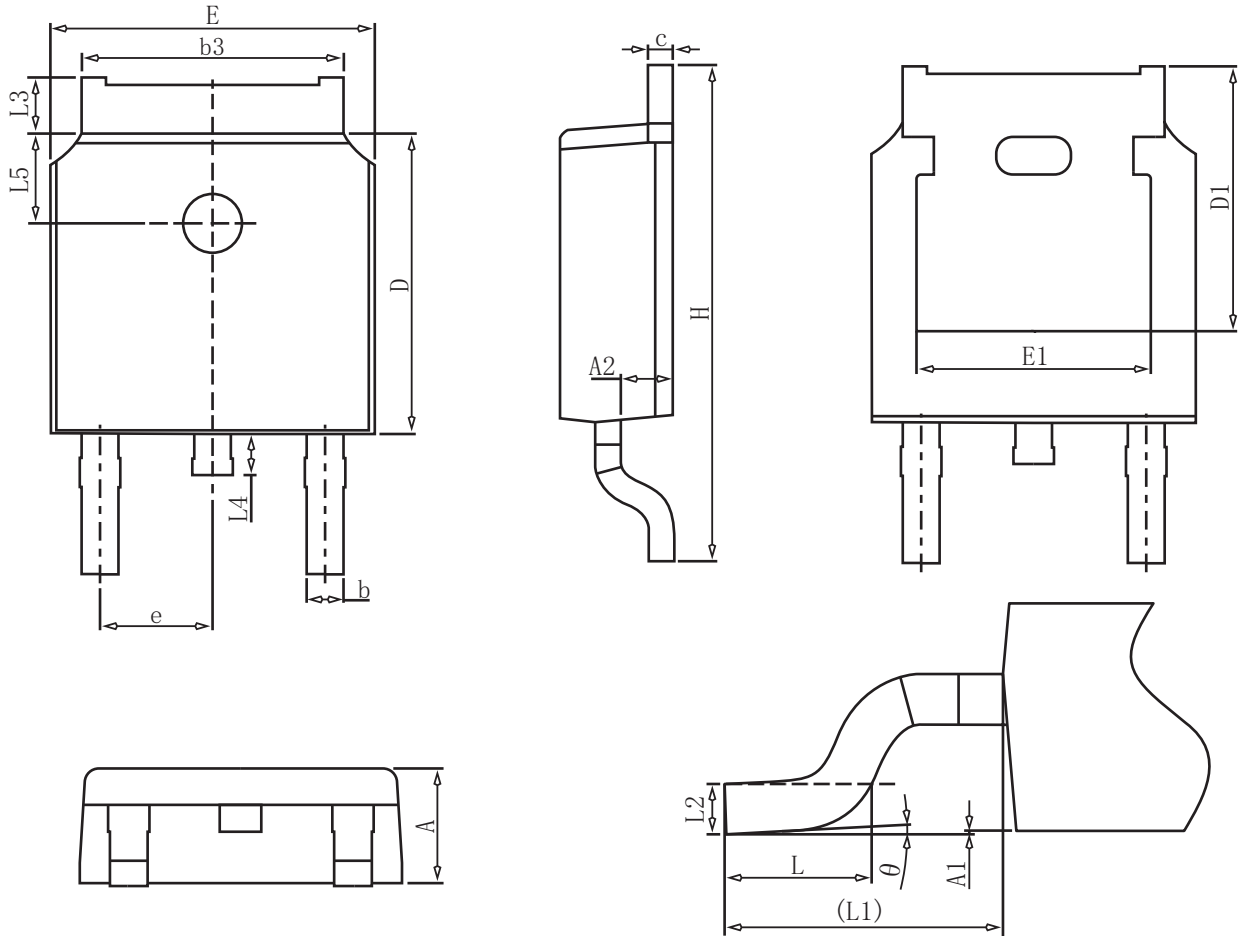


Figure 15. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms (For N-channel)

## TO-252 package information



### COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30REF		
E	6.40	6.60	6.80
E1	4.63	-	-
e	2.286BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88	-	1.28
L4	0.50	-	1.00
L5	1.65	1.80	1.95
$\theta$	0°	-	8°